<u>REMARKS</u>

Applicants respectfully request reconsideration of the prior art rejection set forth by

the Examiner under 35 USC §§102 and 103. Applicants respectfully submit that the prior art

references of record, whether considered alone or in combination, fail to either teach or

suggest Applicants' presently claimed invention. Applicants' claimed invention is directed to

an improved solid state image sensor device and method of driving a solid state image sensor

device which is capable of operating in both an interlaced mode and a progressive mode

wherein all of the signal charges are read out from the imaging device independently without

being combined.

More specifically, the present invention is directed to an imaging device employing a

photodiode and preferably a Hole Accumulation Diode as specified in dependent claims 4-6.

See page 10 of the instant application. In the conventional HAD sensor, it is necessary to

apply a bias voltage Vsub to the substrate for normal operations. Accordingly, a substrate

bias terminal such as the terminal 2e described in the specification is employed.

Conventional HAD sensors did not use adjustment of the bias voltage applied to the substrate

terminal as described and claimed in the instant application.

None of the references cited by the Examiner provide the requisite teaching or

suggestion to result in the claimed subject matter. More specifically, none of the references

describe Applicants' claimed photodiode sensor wherein the substrate bias voltage is adjusted

as specified in the claims depending on the type of read-out operations employed. Simply

put, there is no suggestion in any of the references to apply the substrate bias adjustment

5

techniques described in the Suzuki reference to Applicants claimed photodiode and

specifically the HAD described and claimed in the instant application. A proper rejection

requires that a single reference describes the claimed subject matter or that there be a

combination of references that teach or even suggest that a feature not present in a single

reference would be applicable to the subject matter of a deficient reference. In the present

situation, there is no reference or combination of references that indicates the desirability of

applying bias adjustment depending on the type of operation for a HAD sensor as claimed in

the instant application such that the saturation signal quantity in the progressive scan

mode is substantially equivalent to the saturation signal quantity in the interlaced mode.

Suzuki fails to teach such a device. While, as cited by the Examiner, Column 12,

lines 61 – 65 of the Suzuki reference teach that the saturation signal capacity can be increased

in the full frame reading mode by applying a voltage Vsub to the substrate, Suzuki fails to

teach or suggest wherein the saturation signal capacity after read-out in both modes is

substantially equivalent. (See page 12 of Applicant's disclosure).

One of the deficiencies of the conventional driving techniques for solid state imaging

devices is that in the progressive mode, one signal for each picture element is output so that

the saturation signal quantity becomes half of that compared with the interlaced mode of

operation. The saturation signal quantity is the maximum signal quantity that may be

achieved when the solid state image sensor device outputs the correct signal. In the

conventional mode of operation, during progressive output, there is a decrease in the

saturation signal quantity which results in the degradation of the dynamic range for the

device. Applicants claimed photodiode sensor overcomes the shortcomings and deficiencies

Appl. No. 09/324,823

Amdt. Dated August 4, 2005

Response to Office Action Mailed May 9, 2005

of the prior art by providing bias voltages such that saturation signal quantities in either progressive or interlaced mode are substantially equivalent.

Accordingly, in light of the foregoing, Applicants respectfully submit that the references of record fail to provide the requisite teaching or suggestion to support the rejection of the claims as set forth by the Examiner. Applicants respectfully request that the Examiner now withdraw these rejections and allow all claims in the application.

Respectfully submitted,

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Appl. No. 09/324,823 Amdt. Dated August 4, 2005 Response to Office Action Mailed May 9, 2005

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